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APPLICATION NO).	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/772,586		02/06/2004	Shunpei Yamazaki	740756-2707	2329
22204	7590	12/13/2005	EXAMINER		INER
NIXON PEABODY, LLP				NGUYEN, THANH T	
401 9TH S SUITE 900		١W	·	ART UNIT	PAPER NUMBER
		C 20004-2128		2813	
				DATE MAILED: 12/13/200	5

Please find below and/or attached an Office communication concerning this application or proceeding.

			A
	Application No.	Applicant(s)	
	10/772,586	YAMAZAKI, SHUNPE	1
Office Action Summary	Examiner	Art Unit	
	Thanh T. Nguyen	2813	
The MAILING DATE of this communicate Period for Reply	tion appears on the cover sheet w	th the correspondence addres	ss
A SHORTENED STATUTORY PERIOD FOR WHICHEVER IS LONGER, FROM THE MAIL - Extensions of time may be available under the provisions of 3 after SIX (6) MONTHS from the mailing date of this communic - If NO period for reply is specified above, the maximum statuto - Failure to reply within the set or extended period for reply will, Any reply received by the Office later than three months after earned patent term adjustment. See 37 CFR 1.704(b).	LING DATE OF THIS COMMUNION OF THIS COMMUNION OF THE THIS PROPERTY OF THE THIS PROPERTY OF THE THIS PROPERTY OF THIS PROPERTY	CATION. eply be timely filed ITHS from the mailing date of this commu	
Status			
 1) Responsive to communication(s) filed of the communication (s) filed of the commun	☐ This action is non-final. allowance except for formal matt	·	erits is
Disposition of Claims			
4) Claim(s) 1-24 is/are pending in the apple 4a) Of the above claim(s) 7-12 and 19-2 5) Claim(s) is/are allowed. 6) Claim(s) 1-6 and 13-18 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction	<u>24</u> is/are withdrawn from consider	ation.	
Application Papers			
9) The specification is objected to by the E 10) The drawing(s) filed on is/are: a) Applicant may not request that any objectio Replacement drawing sheet(s) including the	accepted or b) objected to n to the drawing(s) be held in abeyard correction is required if the drawing	nce. See 37 CFR 1.85(a). (s) is objected to. See 37 CFR 1	
Priority under 35 U.S.C. § 119			*
12) Acknowledgment is made of a claim for a) All b) Some * c) None of: 1. Certified copies of the priority doe 2. Certified copies of the priority doe 3. Copies of the certified copies of the application from the International * See the attached detailed Office action for	cuments have been received. cuments have been received in A the priority documents have been Bureau (PCT Rule 17.2(a)).	application No received in this National Sta	nge
Attachment(s) 1) Notice of References Cited (PTO-892) 2) Notice of Draftsperson's Patent Drawing Review (PTO-		Summary (PTO-413) s)/Mail Date	
3) Information Disclosure Statement(s) (PTO-1449 or PTo Paper No(s)/Mail Date 2/23/05.		nformal Patent Application (PTO-15	2)

DETAILED ACTION

Election/Restrictions

Applicant's election with traverse of specie III, claims 13-18 in the reply filed on 9/22/05 is acknowledged. The traversal is on the ground(s) that semiconductor device and display device are used together, and a method for producing a semiconductor device also can be used in a method for producing a display device using a semiconductor device. This is not found persuasive because species I, III (claims 1-6, 13-18) are drawn to a method for *producing a semiconductor device* while species II, IV (claims 7-12, 19-24) are drawn to a method for *using the semiconductor device*. Producing a device and using a device are two distinct inventions.

Claims 7-12, 19-24 would require further search and for the reason of the last Office Action.

The requirement is still deemed proper and is therefore made FINAL.

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Priority

Acknowledgment is made of applicant's claim for foreign priority under 35 U.S.C. 119 (a)-(d).

Information Disclosure Statement

The information disclosure statement filed 2/23/05 has been considered.

Oath/Declaration

Oath/Declaration filed on 8/4/04 has been considered.

Specification

The title of the invention is not descriptive. A new title is required that is clearly indicative of the invention to which the claims are directed.

Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 1-6, 13-18 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

The limitation "linear plasma" in claims 1-3, 13-15 is indefinite because it is unclear what is "linear plasma". For the rejection of the claims, examiner interprets the limitation as "etching the layer by using plasma generator". It is suggested to delete the limitation or provide the clarity of the term.

Claims 5, 17 are objected because there is a typographical error in line 2 of claims 5, 17. It is suggested to delete "when" after "wherein".

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made

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to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-6, 13-18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Ogawa (U.S. Patent Publication No. 2003/0132987) in view of Mori et al. (JP Patent No. 2000/169977).

Referring to figures 1-67, Ogawa teaches a method for producing a semiconductor device comprising:

forming wiring using g. first solution ejector for ejecting a conductive material (see paragraph# 107, 432),

forming a resist mask on the wiring using a second solution ejector (see paragraphs# 109, 327, 434), and

etching the wiring using an atmosphere plasma device having linear plasma generator using the resist mask as a mask (see paragraph# 329, figures s1-s2).

Regarding to claims 4, 16, the solution ejector has one or more of solution ejection ports (57, paragraph# 210).

Regarding to claims 5, 17, a wiring material, or a resist, or the like is ejected using the solution ejector a substrate is heated (see paragraph# 327).

However, the reference does not teach etching the wiring using an atmospheric-pressure plasma device having a plurality of linearly-arranged plasma generators, and etching the wiring layer at the atmospheric pressure or near-atmospheric pressure

Mori et al. teaches etching the wiring (metal layer) by using high frequency plasma under atmospheric pressure (see abstract, meeting claims 1-3, 5, 13-15, 18).

Therefore, it would have been obvious to a person of ordinary skill in the requisite art at the time of the invention was made would etching the wiring layer by using high frequency plasma under atmospheric pressure in process of Ogawa as taught by Mori et al. because the process would enable to etch the metal easily.

It would be obvious to one ordinary skill in the art to etch the wiring layer using a plurality of linearly-arranged plasma generators with the same process as using in a linearly-arrange plasma generators to etch the wiring layer since it is well-known in the art to repeat the same process for multiple effect. See St. Regis paper, Co. V. Bemis Co. Inc. 193 USPQ 8, 11 (7th circuit 1977) (meeting claims 13-15).

Therefore, it would have been obvious to a person of ordinary skill in the requisite art at the time of the invention was made would etch the wiring using an atmospheric-pressure plasma device having a plurality of linearly-arranged plasma generators in process of Ogawa because the process would provide a uniform etching in the wiring layer.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Thanh Nguyen whose telephone number is (571) 272-1695, or by Email via address Thanh.Nguyen@uspto.gov. The examiner can normally be reached on Monday-Thursday from 6:00AM to 3:30PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carl Whitehead, can be reached on (571) 272-1702. The fax phone number for this Group is (703) 872-9306.

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Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the Group receptionist whose telephone number is (703) 308-0956 (See MPEP 203.08).

> Thanh Nguyen Patent Examiner

Patent Examining Group 2800

TTN